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# **Multiple cracks on the interface between a piezoelectric layer and an orthotropic substrate**

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**Abstract** In the present work, we investigate the problem of multiple cracks on the interface between a piezoelectric layer and an orthotropic substrate. The method of dislocation simulation and singular integral equation are used to solve the crack problem. The theoretical derivation is verified by the classical result in a special case. Numerical results of the stress intensity factor are obtained, and thereby the effects of geometrical parameters and material orthotropy are surveyed. The optimal stiffness ratio of the orthotropic substrate is suggested for the purpose of interfacial fracture prevention, which is significant for the design and assessment of such a kind of smart structures.

# **1 Introduction**

Artificial piezoelectric ceramics generally act as the kernel components to transfer energy or signals between electro-elastic fields in modern smart devices. To gain advanced performance, piezoelectric components are often made as layered structures. The simplest structure is just composed of a piezoelectric layer and a substrate [\[1\]](#page-11-0). Orthotropic polythene composites are sometimes used as the substrate of layered piezoelectric devices to enhance its mechanical performance. In these piezoelectric composites, the interface is an important part that is responsible for the transmission of electro-elastic fields between the layer and the substrate. However, the interface is simultaneously a region that has high stress concentration and thus is subjected to cracking especially when the smart device serves under harsh in situ conditions. Therefore, the problems of interfacial cracks in layered piezoelectric structures have been a focus of the mechanics of piezoelectricity in the past years.

Ru [\[2\]](#page-11-1) derived the exact elementary solution for interfacial cracks between the embedded electrode layer and piezoelectric ceramic and demonstrated that the electro-elastic fields exhibit power singularities without oscillation. Govorukha and Loboda [\[3\]](#page-11-2) studied the tensile cracking problem of the interface between a piezoelectric semi-infinite space and a rigid conductor by the method of contact zone model.

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<span id="page-1-0"></span>**Fig. 1** Multiple interfacial cracks between an orthotropic substrate and a piezoelectric layer

Gu et al. [\[4\]](#page-11-3) investigated the problem of an interfacial crack between two dissimilar piezoelectric layers under mechanical impacts. Guo and Fang [\[5](#page-11-4)] developed an effective simulation method for the problem of interfacial cracking in piezoelectric layers. Huang and Wang [\[6](#page-11-5)] surveyed the dynamic behavior of interacting interfacial cracks between a piezoelectric layer and an elastic substrate. Li and Chen [\[7\]](#page-11-6) performed numerical analysis of interfacial crack tip singularities and the crack tip energy release rates for a permeable interfacial crack in elastic dielectric/piezoelectric bimaterials. Tian and Rajapakse [\[8](#page-11-7)] analyzed the fracture parameters of a penny-shaped crack at the interface of a piezoelectric bimaterial system and discussed their dependence on the material properties, poling orientation, and electric loading. Li and Lee [\[9](#page-11-8)] performed fracture analysis on the arc-shaped interface in a layered cylindrical piezoelectric sensor polarized along its axis by the methods of infinite series and singular integral equation. Hausler et al. [\[10\]](#page-11-9) examined the fracture behavior of metal–piezoceramic interfaces under mechanical and electrical loading by experiments. Shin and Lee [\[11](#page-11-10)] studied the dynamic propagation of an interfacial crack between two dissimilar functionally graded piezoelectric layers under electromechanical loading. Loboda et al. [\[12\]](#page-11-11) investigated the in-plane fracture of a thin isotropic interlayer sandwiched between two identical piezoelectric semi-infinite spaces by considering the zones of electrical saturation and mechanical yielding. Natroshvili et al. [\[13\]](#page-11-12) addressed the three-dimensional interfacial crack problems for metallic-piezoelectric composite bodies and discussed the dependence of the stress singularity exponents on the material parameters.

Sometimes, the elastic substrates may be reinforced by fibers orthogonally to enhance the performances of piezoelectric composites. Therefore, investigation on the fracture behavior of piezoelectric composites with orthotropic substrates has practical significance. However, only few work has been done in this field. Kwon and Meguid [\[14](#page-11-13)] provided the analytical solution for a central crack normal to a piezoelectric–orthotropic interface. Kwon and Lee [\[15\]](#page-11-14) studied the dynamic propagation of an eccentric crack in a piezoelectric layer bonded between two orthotropic elastic layers under the combined anti-plane mechanical shear and in-plane electrical loadings. To our knowledge, none has considered the interfacial fracture problems of piezoelectric composites with orthotropic substrates. In the present work, the problem of multiple cracks on the interface between a piezoelectric layer and an orthotropic substrate is solved by the method of dislocation simulation and singular integral equation [\[16](#page-11-15)[–18\]](#page-11-16). Numerical results of the stress intensity factor are obtained, and the effects of geometrical parameters and stiffness ratio are revealed, which may provide references for the design and assessment of this kind of smart structures.

## **2 Problem formulation**

Illustrated in Fig. [1](#page-1-0) is a composite composed of a piezoelectric layer and an orthotropic substrate. The thickness of the former is  $h_1$  and that of the latter is  $h_2$ . The rectangular coordinate system is established with the rightward *x* axis along the interface and the upward *y* axis along the thickness direction. There are multiple cracks on the interface, occupying the intervals,  $x \in (a_i, b_i)$ ,  $(i = 1, 2, \ldots, n)$ , respectively. The piezoelectric layer is poled along the *z* axis and isotropic in the *xoy* plane.

Assume that the upper and lower surfaces of the composite are free of loading and only the surfaces of the cracks are loaded by equivalent anti-plane shear traction  $-\tau_0$ . The boundary and continuity conditions of the problem take the form

<span id="page-2-0"></span>
$$
\tau_{yz}^{(1)}(x, h_1) = 0; \quad \tau_{yz}^{(2)}(x, -h_2) = 0,\tag{1}
$$

$$
D_{y}^{(1)}(x, h_1) = 0; \quad D_{y}^{(1)}(x, 0) = 0,
$$
\n(2)

$$
\tau_{yz}^{(1)}(x, +0) = \tau_{yz}^{(2)}(x, -0), \quad x \notin (a_i, b_i), \quad i = 1, 2, \dots, n,
$$
\n(3)

$$
w_1(x, +0) = w_2(x, -0), \quad x \notin (a_i, b_i), \quad i = 1, 2, \dots, n,
$$
\n
$$
(4)
$$

$$
\tau_{yz}^{(1)}(x, +0) = \tau_{yz}^{(2)}(x, -0) = -\tau_0, \quad x \in (a_i, b_i), \quad i = 1, 2, \dots, n,
$$
\n(5)

where w and  $\tau$  denote the mechanical displacement and stress. *D* is the electric displacement. The superscripts/subscripts 1 and 2 refer to the quantities of the piezoelectric layer and orthotropic substrate, respectively.

## **3 Fracture analysis**

## 3.1 Fields induced by point dislocation

A convenient way to treat the problem of collinear cracks is to simulate them by continuously distributed dislocations [\[17](#page-11-17)[,18](#page-11-16)], whose density functions are defined by

$$
g_i(x) = \frac{d}{dx} \left[ w_1^{(i)}(x, 0) - w_2^{(i)}(x, 0) \right], \quad (i = 1, 2, \dots, n).
$$
 (6)

<span id="page-2-5"></span>According to Eq. [\(4\)](#page-2-0) and the dislocation-based theory of fracture mechanics, dislocation density functions should satisfy the following single-valuedness conditions [\[19\]](#page-11-18):

<span id="page-2-6"></span>
$$
\int_{a_i}^{b_i} g_i(t) dt = 0, \quad (i = 1, 2, \dots, n).
$$
\n(7)

The solution of continuously distributed dislocations may be obtained by integrating that of a point dislocation. A point dislocation placed on the interface is described by

$$
\frac{d}{dx}[w_1(x, 0) - w_2(x, 0)] = \delta(x - s),
$$
\n(8)

where *s* is the *x* coordinate of the point dislocation.  $\delta$  is the Dirac delta function.

<span id="page-2-4"></span><span id="page-2-1"></span>Separate the Dirac delta function  $\delta(x - s)$  into even and odd parts [\[17](#page-11-17)[,18](#page-11-16)]. Then, Eq. [\(8\)](#page-2-1) becomes

$$
\frac{d}{dx}[w_1(x, 0) - w_2(x, 0)] = \frac{1}{2}[\omega(x) + \lambda(x)],
$$
\n(9)

where

$$
\begin{aligned}\n\omega(x) &= \delta(x+s) + \delta(x-s) \\
\lambda(x) &= \delta(x-s) - \delta(x+s)\n\end{aligned}
$$
\n(10)

<span id="page-2-2"></span>Next, we use the method of Fourier transform to get the electric/elastic field induced by the point dislocation. The basic equations of the piezoelectric layer read [\[20](#page-11-19)]

$$
\tau_{kz}^{(1)} = c_{44}^{(1)} \frac{\partial w_1}{\partial k} + e_{15} \frac{\partial \phi}{\partial k} \nD_k = e_{15} \frac{\partial w_1}{\partial k} - \varepsilon_{11} \frac{\partial \phi}{\partial k} \qquad , k = x, y,
$$
\n(11)

$$
\frac{\partial \tau_{xz}^{(1)}}{\partial x} + \frac{\partial \tau_{yz}^{(1)}}{\partial y} = 0; \frac{\partial D_x}{\partial x} + \frac{\partial D_y}{\partial y} = 0,
$$
\n(12)

where  $\phi$  is the electric potential.  $c_{44}^{(1)}$ ,  $e_{15}$  and  $\varepsilon_{11}$  are the elastic constant, piezoelectric coefficient, and dielectric coefficient.

Generally, it is reasonable to assume that  $c_{44}^{(1)} \varepsilon_{11} + e_{15}^2 \neq 0$ . So, substituting Eq. [\(11\)](#page-2-2) into Eq. [\(12\)](#page-2-2) yields

<span id="page-2-3"></span>
$$
\nabla^2 w_1(x, y) = 0 \n\nabla^2 \phi(x, y) = 0
$$
\n(13)

where  $\nabla^2$  is the Laplacian operator.

The basic equations of the orthotropic substrate are

<span id="page-3-0"></span>
$$
\tau_{zx}^{(2)} = c_{55}^{(2)} \frac{\partial w_2}{\partial x}; \tau_{zy}^{(2)} = c_{44}^{(2)} \frac{\partial w_2}{\partial y}, \tag{14}
$$

$$
\frac{\partial \tau_{zx}^{(2)}}{\partial x} + \frac{\partial \tau_{zy}^{(2)}}{\partial y} = 0,\tag{15}
$$

where  $c_{44}^{(2)}$  and  $c_{55}^{(2)}$  are two elastic constants. Substituting Eq.  $(14)$  into Eq.  $(15)$  gives

<span id="page-3-1"></span>
$$
\alpha^2 \frac{\partial^2 w_2}{\partial x^2} + \frac{\partial^2 w_2}{\partial y^2} = 0,\tag{16}
$$

where  $\alpha = \sqrt{c_{55}^{(2)}/c_{44}^{(2)}}$ .

It deserves noting that  $\omega(x)$  is an even function but  $\lambda(x)$  is an odd function. Therefore, the electric/elastic field induced by  $\omega(x)/2$  has symmetry with respect to the *y* axis, but that by  $\lambda(x)/2$  has anti-symmetry instead.

<span id="page-3-2"></span>Applying Fourier transform to Eqs.  $(13)$  and  $(16)$  with respect to *x*, one can obtain the electric/elastic field produced by  $\omega(x)/2$ :

$$
w_1^{(\omega)}(x, y) = \frac{2}{\pi} \int_{0}^{+\infty} \left[ A_1(\xi) e^{-\xi y} + A_2(\xi) e^{\xi y} \right] \cos(\xi x) d\xi
$$
  

$$
\phi_{\omega}(x, y) = \frac{2}{\pi} \int_{0}^{+\infty} \left[ A_5(\xi) e^{-\xi y} + A_6(\xi) e^{\xi y} \right] \cos(\xi x) d\xi
$$
 (17)

$$
w_2^{(\omega)}(x, y) = \frac{2}{\pi} \int_{0}^{+\infty} [A_9(\xi)e^{-\alpha\xi y} + A_{10}(\xi)e^{\alpha\xi y}] \cos(\xi x) d\xi.
$$
 (18)

<span id="page-3-3"></span>Also by Fourier transform, the electric/elastic field produced by  $\lambda(x)/2$  may be obtained:

$$
w_1^{(\lambda)}(x, y) = \frac{2}{\pi} \int_{0}^{+\infty} [A_3(\xi)e^{-\xi y} + A_4(\xi)e^{\xi y}] \sin(\xi x) d\xi
$$
  

$$
\phi_{\lambda}(x, y) = \frac{2}{\pi} \int_{0}^{+\infty} [A_7(\xi)e^{-\xi y} + A_8(\xi)e^{\xi y}] \sin(\xi x) d\xi
$$
 (19)

$$
w_2^{(\lambda)}(x, y) = \frac{2}{\pi} \int_{0}^{+\infty} \left[ A_{11}(\xi) e^{-\alpha \xi y} + A_{12}(\xi) e^{\alpha \xi y} \right] \sin(\xi x) d\xi.
$$
 (20)

In Eqs. [\(17\)](#page-3-2)–[\(20\)](#page-3-3),  $A_j(\xi)$  ( $j = 1, 2, ..., 12$ ) are undetermined coefficient functions. Referring to Eqs. [\(8\)](#page-2-1) and [\(9\)](#page-2-4), one may obtain the electric/elastic field produced by the point dislocation

<span id="page-3-4"></span>
$$
w_1(x, y) = \frac{2}{\pi} \int_0^{+\infty} (A_1 e^{-\xi y} + A_2 e^{\xi y}) \cos(\xi x) d\xi
$$
  
+  $\frac{2}{\pi} \int_0^{+\infty} (A_3 e^{-\xi y} + A_4 e^{\xi y}) \sin(\xi x) d\xi$   

$$
\phi(x, y) = \frac{2}{\pi} \int_0^{+\infty} (A_5 e^{-\xi y} + A_6 e^{\xi y}) \cos(\xi x) d\xi
$$
  
+  $\frac{2}{\pi} \int_0^{+\infty} (A_7 e^{-\xi y} + A_8 e^{\xi y}) \sin(\xi x) d\xi$  (21)

$$
w_2(x, y) = \frac{2}{\pi} \int_{0}^{+\infty} (A_9 e^{-\alpha \xi y} + A_{10} e^{\alpha \xi y}) \cos(\xi x) d\xi
$$

$$
+ \frac{2}{\pi} \int_{0}^{+\infty} (A_{11} e^{-\alpha \xi y} + A_{12} e^{\alpha \xi y}) \sin(\xi x) d\xi.
$$
(22)

<span id="page-4-0"></span>It follows from Eqs.  $(21)$ ,  $(22)$ ,  $(11)$ , and  $(14)$  that

$$
\tau_{yz}^{(1)}(x, y) = \frac{2}{\pi} \int_{0}^{+\infty} \left[ c_{44}^{(1)} \left( A_2 e^{\xi y} - A_1 e^{-\xi y} \right) + e_{15} \left( A_6 e^{\xi y} - A_5 e^{-\xi y} \right) \right] \xi \cos(\xi x) d\xi
$$

$$
+ \frac{2}{\pi} \int_{0}^{+\infty} \left[ c_{44}^{(1)} \left( A_4 e^{\xi y} - A_3 e^{-\xi y} \right) + e_{15} \left( A_8 e^{\xi y} - A_7 e^{-\xi y} \right) \right] \xi \sin(\xi x) d\xi, \tag{23}
$$

$$
D_{y}(x, y) = \frac{2}{\pi} \int_{0}^{+\infty} \left[ e_{15} \left( A_{2} e^{\xi y} - A_{1} e^{-\xi y} \right) - \varepsilon_{11} \left( A_{6} e^{\xi y} - A_{5} e^{-\xi y} \right) \right] \xi \cos(\xi x) d\xi
$$

$$
+ \frac{2}{\pi} \int_{0}^{+\infty} \left[ e_{15} \left( A_{4} e^{\xi y} - A_{3} e^{-\xi y} \right) - \varepsilon_{11} \left( A_{8} e^{\xi y} - A_{7} e^{-\xi y} \right) \right] \xi \sin(\xi x) d\xi, \tag{24}
$$

$$
\tau_{zy}^{(2)}(x, y) = c_{44}^{(2)} \frac{2}{\pi} \int_{0}^{+\infty} \left( A_{10} e^{\alpha \xi y} - A_9 e^{-\alpha \xi y} \right) \alpha \xi \cos(\xi x) d\xi \n+ c_{44}^{(2)} \frac{2}{\pi} \int_{0}^{+\infty} \left( A_{12} e^{\alpha \xi y} - A_{11} e^{-\alpha \xi y} \right) \alpha \xi \sin(\xi x) d\xi.
$$
\n(25)

Using Eqs.  $(21)$ – $(25)$ , one may transform Eqs.  $(1)$ – $(3)$  and  $(9)$  into integral equations. Separating their even and odd parts with respect to *x* and then applying cosine and sine transforms accordingly yield a system of algebraic equations. The coefficient matrix **M** of these algebraic equations is given in the Appendix. Solving these algebraic equations gives

$$
A_j(\xi) = [\beta_{j1}(\xi)\cos(\xi s) - \beta_{j2}(\xi)\sin(\xi s)]/(2\xi), \quad (j = 1, 2, ..., 12),
$$
 (26)

<span id="page-4-1"></span>where  $\beta_{j1}(\xi)$  and  $\beta_{j2}(\xi)$  ( $j = 1, 2, ..., 12$ ) are the first and second columns of elements of **M**<sup>−1</sup>. Here, the superscript −1 represents the inverse matrix.

<span id="page-4-4"></span>Substituting Eq.  $(26)$  into Eq.  $(25)$  leads to

$$
\tau_{yz}(x,0) = \sqrt{c_{44}^{(2)} c_{55}^{(2)}} \frac{1}{\pi} \int_{0}^{+\infty} [Q_1(\xi) \sin(\xi s) + Q_3(\xi) \cos(\xi s)] \cos(\xi x) d\xi
$$
  
 
$$
+ \sqrt{c_{44}^{(2)} c_{55}^{(2)}} \frac{1}{\pi} \int_{0}^{+\infty} [Q_2(\xi) \cos(\xi s) + Q_4(\xi) \sin(\xi s)] \sin(\xi x) d\xi,
$$
 (27)

where  $Q_1$ ,  $Q_2$ ,  $Q_3$  and  $Q_4$  are four dimensionless functions defined by

<span id="page-4-3"></span>
$$
Q_1(\xi) = \beta_{92}(\xi) - \beta_{(10)2}(\xi); \quad Q_3(\xi) = \beta_{(10)1}(\xi) - \beta_{91}(\xi) \equiv 0
$$
  
\n
$$
Q_2(\xi) = \beta_{(12)1}(\xi) - \beta_{(11)1}(\xi); \quad Q_4(\xi) = \beta_{(11)2}(\xi) - \beta_{(12)2}(\xi) \equiv 0
$$
\n(28)

<span id="page-4-2"></span>When  $\xi \to \infty$ , the asymptotic values of  $Q_1$  and  $Q_2$  are

$$
\lim_{\xi \to \infty} Q_1(\xi) = -\lim_{\xi \to \infty} Q_2(\xi) = q \neq 0,
$$
\n(29)

where *q* is a dimensionless constant given by

$$
q = \frac{c_{44}^{(1)}\varepsilon_{11} + e_{15}^2}{c_{44}^{(1)}\varepsilon_{11} + e_{15}^2 + \alpha c_{44}^{(2)}\varepsilon_{11}}.
$$
\n(30)

<span id="page-5-1"></span>Considering Eqs. [\(28\)](#page-4-2) and [\(29\)](#page-4-3), one can reformulate Eq. [\(27\)](#page-4-4) into

$$
\tau_{yz}(x,0) = \sqrt{c_{44}^{(2)} c_{55}^{(2)}} \frac{1}{\pi} \left[ \frac{q}{s-x} + R(s,x) \right],\tag{31}
$$

<span id="page-5-0"></span>where  $R(s, x)$  is a function defined by

$$
R(s, x) = \int_{0}^{+\infty} [Q_1(\xi) - q] \sin(\xi s) \cos(\xi x) d\xi
$$
  
+ 
$$
\int_{0}^{+\infty} [Q_2(\xi) + q] \cos(\xi s) \sin(\xi x) d\xi.
$$
 (32)

In the derivation of Eq.  $(32)$ , the following integral formula is used [\[21](#page-11-20)]:

$$
\int_{0}^{\infty} \sin(\xi s) \cos(\xi x) d\xi = \frac{1}{2} \left( \frac{1}{s+x} + \frac{1}{s-x} \right).
$$
 (33)

Equation [\(31\)](#page-5-1) gives the stress  $\tau_{yz}(x, 0)$  on the interface induced by a point dislocation placed at  $x = s$  on the *x* axis.

As indicated by Eq. [\(6\)](#page-2-5), the multiple cracks on the interface in Fig. [1](#page-1-0) can be simulated by dislocations continuously distributed in the intervals,  $x \in (a_i, b_i)$ ,  $(i = 1, 2, ..., n)$ , respectively. According to the theory of Green's function and the principle of superposition, the stress  $\tau_{yz}(x, 0)$  induced by these continuously distributed dislocations can be formulated as

$$
\tau_{yz}(x,0) = \sqrt{c_{44}^{(2)} c_{55}^{(2)}} \frac{1}{\pi} \sum_{j=1}^{n} \int_{a_j}^{b_j} g_j(s) \left[ \frac{q}{s-x} + R(s,x) \right] ds.
$$
 (34)

## <span id="page-5-2"></span>3.2 Singular integral equation

Substituting Eq.  $(34)$  into Eq.  $(5)$  gives

*b j*

$$
\frac{1}{\pi} \sum_{j=1}^{n} \int_{a_j}^{b_j} g_j(s_j) \left[ \frac{1}{s_j - x_k} + q^{-1} R(s_j, x_k) \right] ds_j = \frac{-\tau_0}{q \sqrt{c_{44}^{(2)} c_{55}^{(2)}}}, x_k \in (a_k, b_k),\tag{35}
$$

<span id="page-5-4"></span>where  $k = 1, 2, \ldots, n$ . Obviously, only when  $s_j = x_k$  would the integral associated with  $(s_j - x_k)^{-1}$  have the Cauchy type singularity.

<span id="page-5-3"></span>For the convenience of numerical computation, let's introduce the following dimensionless quantities

$$
\begin{aligned}\n\tilde{s}_j &= (s_j - c_{0j})/a_{0j} \in (-1, 1) \\
\tilde{x}_j &= (x_j - c_{0j})/a_{0j} \in (-1, 1)\n\end{aligned}\n\bigg\}, \quad (j = 1, 2, \dots, n),\n\tag{36}
$$

where  $a_{0j} = (b_j - a_j)/2$  is the half-length of the *j*th crack and  $c_{0j} = (b_j + a_j)/2$  is the *x* coordinate of its center.

Using Eq. [\(36\)](#page-5-3), one can recast Eq. [\(35\)](#page-5-4) into standard form:

1

$$
\sum_{j=1}^{n} \frac{1}{\pi} \int_{-1}^{1} \tilde{g}_{j}(\tilde{s}_{j}) \left[ \frac{a_{0j}}{a_{0j}\tilde{s}_{j} + c_{0j} - a_{0k}\tilde{x}_{k} - c_{0k}} + \tilde{R}(\tilde{s}_{j}, \tilde{x}_{k}) \right] d\tilde{s}_{j} = \frac{-\tau_{0}}{q \sqrt{c_{44}^{(2)} c_{55}^{(2)}}},
$$
(37)

<span id="page-6-0"></span>where  $k = 1, 2, \ldots, n$  and

$$
\begin{aligned}\n\tilde{R}(\tilde{s}_j, \tilde{x}_k) &= a_{0j} q^{-1} R(a_{0j} \tilde{s}_j + c_{0j}, \ a_{0k} \tilde{x}_k + c_{0k}) \\
\tilde{g}_j(\tilde{s}_j) &= g_j(a_{0j} \tilde{s}_j + c_{0j})\n\end{aligned} \tag{38}
$$

According to the theory of Cauchy singular integral equation [\[22](#page-11-21)], the dislocation density functions  $\tilde{g}_i(\tilde{s}_i)$  $(j = 1, 2, \ldots, n)$  in Eq. [\(37\)](#page-6-0) have the square-root type singularity. Therefore, by introducing undetermined dimensionless non-singular functions  $f_j(\tilde{s}_j)$  ( $j = 1, 2, ..., n$ ) and separating the singular part, the dislocation density functions may be expressed as

$$
\tilde{g}_j(\tilde{s}_j) = \frac{\tau_0}{q\sqrt{c_{44}^{(2)}c_{55}^{(2)}}} \frac{f_j(\tilde{s}_j)}{\sqrt{1-\tilde{s}_j^2}}, \quad (j=1, 2, ..., n). \tag{39}
$$

<span id="page-6-2"></span><span id="page-6-1"></span>Then, using the method of Lobatto-Chebyshev quadrature, one can transform Eqs. [\(37\)](#page-6-0) and [\(7\)](#page-2-6) into algebraic equations:

$$
\sum_{r=0}^{m} \chi_r \sum_{j=1}^{n} f_j(\tilde{s}_{jr}) \left[ \frac{a_{0j}}{a_{0j}\tilde{s}_{jr} + c_{0j} - a_{0k}\tilde{x}_{kt} - c_{0k}} + \tilde{R}(\tilde{s}_{jr}, \tilde{x}_{kt}) \right] = -m,
$$
\n(40)

$$
\sum_{r=0}^{m} \chi_r f_k(\tilde{s}_{kr}) = 0, \qquad (41)
$$

where  $k = 1, 2, \ldots, n; t = 1, 2, \ldots, m$ . *m* is the node number of the numerical quadrature.  $\chi_i$  $(i = 1, 2, \ldots, m)$  are the weighting coefficients given by  $\chi_0 = \chi_m = 1/2$  and  $\chi_1 = \cdots = \chi_{m-1} = 1$ . The discrete values of  $\tilde{s}_j$  and  $\tilde{x}_k$  are the roots of the Chebyshev polynomials of the first and second kind, respectively:

$$
\tilde{s}_{jr} = \cos(r\pi/m), \quad (r = 0, 1, ..., m)
$$
  
\n
$$
\tilde{x}_{kt} = \cos[(2t - 1)\pi/(2m)], \quad (t = 1, 2, ..., m)
$$
\n(42)

One may solve Eqs. [\(40\)](#page-6-1) and [\(41\)](#page-6-1) numerically to get the solutions of  $f_j(\tilde{s}_j)$  ( $j = 1, 2, ..., n$ ), which can be further used to determine the stress intensity factor (SIF).

## 3.3 Stress intensity factor

The SIFs of the two tips of every crack is defined by

$$
K_{ak} = \lim_{x \to a_k^-} \tau_{yz}(x, 0) \sqrt{2\pi (a_k - x)}
$$
  
\n
$$
K_{bk} = \lim_{x \to b_k^+} \tau_{yz}(x, 0) \sqrt{2\pi (x - b_k)}
$$
,  $(k = 1, 2, ..., n).$  (43)

<span id="page-6-4"></span>According to Eq. [\(34\)](#page-5-2), the singular part of  $\tau_{vz}(x, 0)$  is

$$
\lim_{x_k \to a_k^-} \tau_{yz}(x, 0) = q \sqrt{c_{44}^{(2)} c_{55}^{(2)}} \frac{1}{\pi} \lim_{\tilde{x}_k \to -1^-} \int_{-1}^1 \frac{\tilde{g}_k(\tilde{s}_k)}{\tilde{s}_k - \tilde{x}_k} d\tilde{s}_k
$$
\n
$$
\lim_{x_k \to b_k^+} \tau_{yz}(x, 0) = q \sqrt{c_{44}^{(2)} c_{55}^{(2)}} \frac{1}{\pi} \lim_{\tilde{x}_k \to 1^+} \int_{-1}^1 \frac{\tilde{g}_k(\tilde{s}_k)}{\tilde{s}_k - \tilde{x}_k} d\tilde{s}_k
$$
\n(44)

<span id="page-6-3"></span>where  $k = 1, 2, ..., n$ .

<span id="page-7-0"></span>Substituting Eq. [\(39\)](#page-6-2) into Eq. [\(44\)](#page-6-3), one may rewrite the singular part of  $\tau_{vz}(x, 0)$  as [\[23](#page-11-22)]

$$
\lim_{x_k \to a_k^-} \tau_{yz}(x, 0) = \tau_0 \lim_{\tilde{x}_k \to -1^-} \frac{f_k(-1)}{\sqrt{\tilde{x}_k^2 - 1}} \left\{ , (k = 1, 2, ..., n). \atop x_k \to b_k^+} \tau_{yz}(x, 0) = \tau_0 \lim_{\tilde{x}_k \to 1^+} \frac{-f_k(1)}{\sqrt{\tilde{x}_k^2 - 1}} \right\}, (k = 1, 2, ..., n). \tag{45}
$$

In the derivation of Eq.  $(45)$ , the following integral formula is used [\[24](#page-11-23)]:

$$
\frac{1}{\pi} \int_{-1}^{1} \frac{1}{(\tilde{s} - \tilde{x})\sqrt{1 - \tilde{s}^2}} d\tilde{s} = \begin{cases} \frac{-1}{\sqrt{\tilde{x}^2 - 1}}, & \tilde{x} > 1, \\ 0, & |\tilde{x}| < 1 \\ \frac{1}{\sqrt{\tilde{x}^2 - 1}}, & \tilde{x} < -1. \end{cases}
$$
(46)

Substituting Eq. [\(45\)](#page-7-0) into Eq. [\(43\)](#page-6-4) yields

$$
\begin{aligned} K_{ak} &= \tau_0 f_k(-1) \sqrt{\pi a_{0k}} \\ K_{bk} &= -\tau_0 f_k(1) \sqrt{\pi a_{0k}} \end{aligned} \bigg\}, \quad (k = 1, \ 2, \ \ldots, \ n). \tag{47}
$$

<span id="page-7-1"></span>Because  $\tau_0\sqrt{\pi a_{0k}}$  has the dimension of SIF, we can use it to normalize the SIFs in Eq. [\(47\)](#page-7-1). So, in the numerical computation, we only calculate the following dimensionless SIFs:

$$
\begin{aligned} K_{ak} &= f_k(-1) \\ K_{bk} &= -f_k(1) \end{aligned} \bigg\}, \quad (k = 1, \ 2, \ \ldots, \ n). \tag{48}
$$

# 3.4 Verification

One can use a special case to verify the foregoing derivation. Assume that  $e_{15} = 0$ ,  $c_{55}^{(2)} = c_{44}^{(2)} = c_{44}^{(1)} = c_{44}$ and  $h_1 = h_2 \rightarrow \infty$  $h_1 = h_2 \rightarrow \infty$  $h_1 = h_2 \rightarrow \infty$ ; then, the problem in Fig. 1 becomes that of collinear cracks in an elastic isotropic plane. In this special case, we have  $\alpha = 1$ ,  $q = 1/2$  and  $\lim_{h_1 = h_2 \to \infty} R(s, x) = 0$ . What is more, because the problem is antisymmetric with respect to the *x* axis, it is sufficient to study only the upper half-plane. Therefore, the dislocation density function can be defined as

$$
G_j(x) = \frac{d}{dx} w_j(x, 0^+) = \frac{1}{2} g_j(x), \quad (j = 1, 2, \dots, n). \tag{49}
$$

Then, Eq. [\(35\)](#page-5-4) reduces to

$$
\sum_{j=1}^{n} \frac{1}{\pi} \int_{a_j}^{b_j} \frac{G_j(s_j)}{s_j - x_k} ds_j = -\frac{\tau_0}{c_{44}}, \quad x_k \in (a_k, b_k). \tag{50}
$$

<span id="page-7-2"></span>If there is only one crack lying in the interval  $x \in (-a, a)$ , Eq. [\(50\)](#page-7-2) further reduces to

$$
\frac{1}{\pi} \int_{-a}^{a} \frac{G(s)}{s - x} ds = -\frac{\tau_0}{c_{44}}, \quad x \in (-a, \ a).
$$
\n(51)

<span id="page-7-3"></span>Equation [\(51\)](#page-7-3) is the classical singular integral equation for a mode III crack in an elastic isotropic plane. The degradation from Eq. [\(35\)](#page-5-4) to Eq. [\(51\)](#page-7-3) validates the foregoing theoretical derivation.

#### **4 Numerical results and discussion**

Assume that the piezoelectric layer is PZT-5H ceramic. Its material constants are  $c_{44}^{(1)} = 3.53 \times$  $10^{10}$  N/m<sup>2</sup>,  $\varepsilon_{11} = 151.0 \times 10^{-10}$  C/(Vm) and  $e_{15} = 17.0$  C/m<sup>2</sup>. The substrate is orthotropic polythene composite, and its elastic constants are  $c_{44}^{(2)} = 1.765 \times 10^{10} \text{ N/m}^2$  and  $c_{55}^{(2)} = \alpha^2 c_{44}^{(2)}$ . For the convenience of computation, we only consider the special case of two interfacial cracks in this section.



<span id="page-8-0"></span>**Fig. 2** The asymptotic behaviors of the dimensionless kernel function  $(h_1 = h_2 = 10 \text{ mm}; a_{02} = 2a_{01} = 5 \text{ mm}; d_0 = 1 \text{ mm};$  $c_{44}^{(2)} = 17.65$  GPa;  $\alpha = 1.5$ )

#### 4.1 Computational accuracy

At the beginning of computation, it is necessary to survey the convergence behavior of the dimensionless non-singular kernel function  $\tilde{R}(\tilde{s}_i, \tilde{x}_k)$ ,  $(j = 1, 2; k = 1, 2)$ . As indicated by Eq. [\(32\)](#page-5-0), this kernel function involves infinite integral. A practical method to quadrature this infinite integral is to truncate it into a finite integral on the interval (0, *N*), where the value of the upper limit *N* depends on the convergence speed of the integration [\[23\]](#page-11-22). Illustrated in Fig. [2](#page-8-0) is the variation of the kernel function versus the upper limit *N*. It is indicated that the kernel function converges very well.  $N = 500$  is quite enough to guarantee a precision of <sup>1</sup>.0×10−6, which is sufficient for most engineering applications. Therefore, *<sup>N</sup>* is fixed at 500 in the following computation.

In addition, the quadrature node number *m* is another parameter affecting the accuracy of the numerical results. Calculation reveals that  $m = 20$  is well enough to ensure a precision of  $1.0 \times 10^{-6}$  with satisfactory computational efficiency.

# 4.2 Parametric studies

#### *4.2.1 Effect of geometrical parameters*

Figure [3](#page-9-0) shows the effects of crack space and structure thickness on the SIFs. If the crack space  $d_0 \ge 10a_0$ , the variation of  $d_0$  nearly does not affect the SIF. As  $d_0$  decreases from  $10a_0$  to  $5a_0$ , the SIF only increases slightly. If  $d_0$  continues to decrease from  $5a_0$ , the SIF begins to increase notably. When  $d_0 \rightarrow 0$ , the SIFs of the two inner tips even experience a singular increase, which would gives rise to a sudden interlinkage between the two cracks.

It deserves noting that in Fig. [3,](#page-9-0) the SIFs of the two outer tips also increase as the crack space decreases, although their increase is smaller than that of the two inner tips. This is because the two cracks in Fig. [3](#page-9-0) are so short than their outer tips also fall into the affected region of the crack space. Further computation indicates that if the cracks are long enough the variation of the crack space would have a vanishing effect on the SIFs of the outer tips.

Figure [3](#page-9-0) also reveals that the interfacial cracks in a structure with smaller thickness would have larger SIFs. This is because the surfaces of a thinner structure affect the interfacial cracks more notably, which leads to the increase in their SIFs. As the half thickness *h* becomes larger than 10*a*<sub>0</sub>, the effect of the structure surfaces becomes negligible and the SIFs then get insensitive to the variation of the structure thickness.

#### *4.2.2 Crack opening mouth*

It follows from Eq. [\(6\)](#page-2-5) that we can calculate the dislocation between the crack surfaces by numerical integration after the numerical solution of the dislocation density function is obtained. Figure [4](#page-9-1) presents the dislocations



<span id="page-9-0"></span>**Fig. 3** The effects of crack space and structure thickness on the SIFs  $(a_0 = 1 \text{ mm}; h_1 = h_2 = h; c_{44}^{(2)} = 17.65 \text{ GPa}; \alpha = 1.5)$ 



<span id="page-9-1"></span>**Fig. 4** The dislocations of the cracks  $(h_1 = h_2 = 10 \text{ mm}; a_{02} = 2a_{01} = 2 \text{ mm}; \tau_0 = 5 \text{ MPa}; c_{44}^{(2)} = 17.65 \text{ GPa}; \alpha = 1.5)$ 

of two interfacial cracks when the crack-surface traction is prescribed as  $\tau_0 = 5$  MPa. In this figure,  $\tilde{s} = -1.0$ corresponds to the inner-side tip of crack 2 and the outer-side tip of crack 1, while  $\tilde{s} = 1.0$  to the inner-side tip of crack 1 and the outer-side tip of crack 2. It is revealed that the dislocation curves of both cracks become oblique to the inner side as the crack space  $d_0$  decreases. This is in consistence with the common sense of fracture mechanics.

# *4.2.3 Effect of orthotropy*

Anti-plane deformation of the orthotropic substrate involves two stiffness coefficients,  $c_{55}^{(2)}$  and  $c_{44}^{(2)}$ , and their ratio  $c_{55}^{(2)}/c_{44}^{(2)}$  reflects the degree of material orthotropy. In all the foregoing computation, this ratio is fixed (see Figs. [2,](#page-8-0) [3,](#page-9-0) [4:](#page-9-1)  $\alpha = 1.5$ ). This subsection continues to examine the effect of the stiffness ratio  $c_{55}^{(2)}/c_{44}^{(2)}$  on the interfacial cracks. Figure [5](#page-10-0) shows that as  $c_{55}^{(2)}/c_{44}^{(2)}$  decreases from 1.0 to 0.1, the SIFs increase remarkably. However, the SIFs nearly keep unchanged when  $c_{55}^{(2)}/c_{44}^{(2)}$  increases from 1.0 to 10.0. This is consistent with the results of some related previous studies. For example, see Figs. [3](#page-9-0) and [4](#page-9-1) of Matbuly and Nassar [\[25](#page-11-24)], and Figs. 7 and 8 of Li and Duan [\[26\]](#page-11-25). Therefore, in order to prevent the interfacial fracture, it is better to choose an orthotropic substrate with its stiffness ratio lager than 1.0. If the stiffness ratio of the orthotropic substrate is less than 1.0, the risk of interface fracture would be enhanced.



<span id="page-10-0"></span>**Fig. 5** The effects of  $c_{55}^{(2)}/c_{44}^{(2)}$  on the SIFs (*h*<sub>1</sub> = *h*<sub>2</sub> = 10 mm;  $a_{02}$  = 3 mm;  $a_{01}$  = 1 mm;  $d_0$  = 1 mm;  $c_{44}^{(2)}$  = 17.65 GPa)

# **5 Conclusions**

Interfacial fracture is a typical failure of layered piezoelectric composites. Fracture analysis is an important way to assess the safety of the interface and to find some feasible approaches to prevent interfacial fracture. In the present work, Fracture analysis is performed on a smart composite consisting of a piezoelectric layer and an orthotropic substrate with multiple cracks lying on the interface. The cracks are simulated as continuously distributed dislocations, and then the method of singular integral equation is used to solve the problem. The derivation is verified by the classical result in a special case. Numerical results of the stress intensity factor are used to survey the effects of geometrical and physical parameters. The optimal stiffness ratio of the orthotropic substrate is suggested for the purpose of interfacial fracture prevention.

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# **Appendix**

The nonvanishing elements of the coefficient matrix *M* are

$$
M_{13} = 1; M_{14} = 1; M_{1(11)} = -1; M_{1(12)} = -1;
$$
  
\n
$$
M_{21} = 1; M_{22} = 1; M_{29} = -1; M_{2(10)} = -1;
$$
  
\n
$$
M_{31} = -c_{44}^{(1)} e^{-\xi h_1}; M_{32} = c_{44}^{(1)} e^{\xi h_1}; M_{35} = -e_{15} e^{-\xi h_1}; M_{36} = e_{15} e^{\xi h_1};
$$
  
\n
$$
M_{43} = -c_{44}^{(1)} e^{-\xi h_1}; M_{44} = c_{44}^{(1)} e^{\xi h_1}; M_{47} = -e_{15} e^{-\xi h_1}; M_{48} = e_{15} e^{\xi h_1};
$$
  
\n
$$
M_{59} = e^{\alpha \xi h_2}; M_{5(10)} = -e^{-\alpha \xi h_2};
$$
  
\n
$$
M_{6(11)} = e^{\alpha \xi h_2}; M_{6(12)} = -e^{-\alpha \xi h_2};
$$
  
\n
$$
M_{71} = -e_{15} e^{-\xi h_1}; M_{72} = e_{15} e^{\xi h_1}; M_{75} = \varepsilon_{11} e^{-\xi h_1}; M_{76} = -\varepsilon_{11} e^{\xi h_1};
$$
  
\n
$$
M_{83} = -e_{15} e^{-\xi h_1}; M_{84} = e_{15} e^{\xi h_1}; M_{87} = \varepsilon_{11} e^{-\xi h_1}; M_{88} = -\varepsilon_{11} e^{\xi h_1};
$$
  
\n
$$
M_{91} = -e_{15}; M_{92} = e_{15}; M_{95} = \varepsilon_{11}; M_{96} = -\varepsilon_{11};
$$
  
\n
$$
M_{(10)3} = -e_{15}; M_{(10)4} = e_{15}; M_{(10)7} = \varepsilon_{11}; M_{(10)8} = -\varepsilon_{11};
$$
  
\n
$$
M_{(11)1} = -c_{44}^{(1)}; M_{(11)2} = c_{44}^{
$$

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